

Notice of References Cited	Application/Control No. 10/629,554	Applicant(s)/Patent Under Reexamination AKAGAWA ET AL.	
	Examiner Woo H. Choi	Art Unit 2189	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0054093	12-2001	Iwatani, Sawao	709/223
	B	US-2003/0229764 A1	12-2003	Ohno et al.	711/147
	C	US-2004/0068561 A1	04-2004	Yamamoto et al.	709/224
	D	US-2003/0055933 A1	03-2003	Ishizaki et al.	709/223
	E	US-2004/0083401 A1	04-2004	Furukawa et al.	714/007
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-278905	09-2002	Japan	(English translation)	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.